

<b>Notice of References Cited</b>	Application/Control No. 10/821,454		Applicant(s)/Patent Under Reexamination WANG, CHANGZHOU	
	Examiner Joseph P. Hirl		Art Unit 2129	Page 1 of 1

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*	B	US-2004/0260517	12-2004	Ding et al.	702/186
*	C	US-6,526,405	02-2003	Mannila et al.	707/6
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*	U	John F. Roddick et al., A Survey of Temporal Knowledge Discovery Paradigms and Methods, August 2002, IEEE, 1041-4347/02, 750-767			
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.